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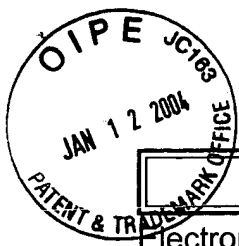
Electronic Filing System (EFS) Data  
Electronic Patent Application Submission  
USPTO Use Only

EFS ID: 53475  
Application ID: 10675259  
Title of Invention: Method for Controlling Trench  
Depth in Shallow Trench  
Isolation Features  
First Named Inventor: Mario Pita  
Domestic/Foreign Application: Domestic Application  
Filing Date: 2003-09-30  
Effective Receipt Date: 2004-01-12  
Submission Type: Information Disclosure  
Statement  
Filing Type:  
Confirmation number: 4047  
Attorney Docket Number: 075903-240




Total Fees Authorized:

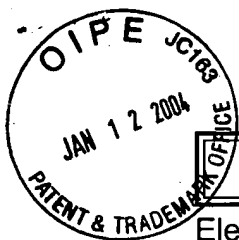
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**TRANSMITTAL**

Electronic Version v1.1

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<b>Title of Invention</b>	<b>Method for Controlling Trench Depth in Shallow Trench Isolation Features</b>									
<p>Application Number: 10/675259 </p> <p>Date: 2003-09-30</p> <p>First Named Applicant: Mario Pita</p> <p>Confirmation Number: 4047</p> <p>Attorney Docket Number: 075903-240</p>										
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<table border="1"><thead><tr><th>Submitted by:</th><th>Elec. Sign.</th><th>Sign. Capacity</th></tr></thead><tbody><tr><td>John L. DeAngelis Jr. Registered Number: 30,622</td><td>/John L. DeAngelis, Jr./</td><td>Attorney</td></tr></tbody></table>			Submitted by:	Elec. Sign.	Sign. Capacity	John L. DeAngelis Jr. Registered Number: 30,622	/John L. DeAngelis, Jr./	Attorney		
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<table><tr><td>Documents being submitted</td><td>Files</td></tr><tr><td>us-ids</td><td>Agere240-usidst.xml</td></tr><tr><td></td><td>us-ids.dtd</td></tr><tr><td></td><td>us-ids.xsl</td></tr></table>			Documents being submitted	Files	us-ids	Agere240-usidst.xml		us-ids.dtd		us-ids.xsl
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<b>Comments</b>										



## ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

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<p>Application Number: 10/675259 </p> <p>Confirmation Number: 4047</p> <p>First Named Applicant: Mario Pita</p> <p>Attorney Docket Number: 075903-240</p> <p>Art Unit: 1765</p> <p>Search string: ( 5229316 or 5413966 or 6207576 or 6277710 or 6281068 or 6348389 or 6426298 or 6444581 or 6582974 ).pn.</p> <p><b>US Patent Documents</b></p> <p>Note: Applicant is not required to submit a paper copy of cited US Patent Documents</p> <table border="1"><thead><tr><th>init</th><th>Cite.No.</th><th>Patent No.</th><th>Date</th><th>Patentee</th><th>Kind</th><th>Class</th><th>Subclass</th></tr></thead><tbody><tr><td></td><td>1</td><td>5229316</td><td>1993-07-20</td><td>Lee, et al</td><td></td><td></td><td></td></tr><tr><td></td><td>2</td><td>5413966</td><td>1995-05-09</td><td>Schoenborn</td><td></td><td></td><td></td></tr><tr><td></td><td>3</td><td>6207576</td><td>2001-03-27</td><td>Wang, et al</td><td></td><td></td><td></td></tr><tr><td></td><td>4</td><td>6277710</td><td>2001-08-21</td><td>Kim, et al</td><td></td><td></td><td></td></tr><tr><td></td><td>5</td><td>6281068</td><td>2001-08-28</td><td>Coronel, et al</td><td></td><td></td><td></td></tr><tr><td></td><td>6</td><td>6348389</td><td>2002-02-19</td><td>Chou, et al</td><td></td><td></td><td></td></tr><tr><td></td><td>7</td><td>6426298</td><td>2002-07-30</td><td>Chen, et al</td><td></td><td></td><td></td></tr><tr><td></td><td>8</td><td>6444581</td><td>2002-09-03</td><td>Buschner, et al</td><td></td><td></td><td></td></tr><tr><td></td><td>9</td><td>6582974</td><td>2003-06-24</td><td>Lui, et al</td><td></td><td></td><td></td></tr></tbody></table> <p><b>Signature</b></p> <table border="1"><tr><td>Examiner Name</td><td>Date</td></tr><tr><td></td><td></td></tr></table>		init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass		1	5229316	1993-07-20	Lee, et al					2	5413966	1995-05-09	Schoenborn					3	6207576	2001-03-27	Wang, et al					4	6277710	2001-08-21	Kim, et al					5	6281068	2001-08-28	Coronel, et al					6	6348389	2002-02-19	Chou, et al					7	6426298	2002-07-30	Chen, et al					8	6444581	2002-09-03	Buschner, et al					9	6582974	2003-06-24	Lui, et al				Examiner Name	Date		
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